

RF beam diagnostics

2nd part

A. Mostacci

With the help of

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HZB Helmholtz
Zentrum Berlin

OUTLINE

RF beam diagnostics – 2nd lecture

Longitudinal diagnostics

Bunch arrival monitor (passive cavity)

Bunch length diagnostics

RF deflector for bunch length measurement

Design of the structure and realisation issue

Beam measurement and calibration

Novel ideas

Only 1 example from the design, the realisation to the beam measurement

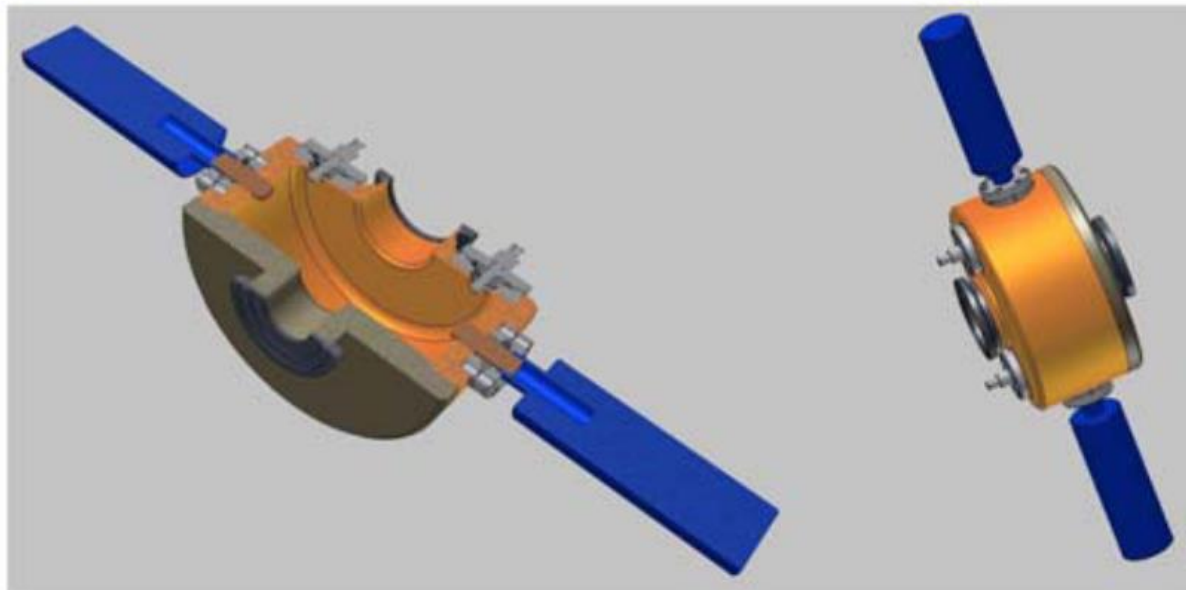
General techniques

Higher frequencies

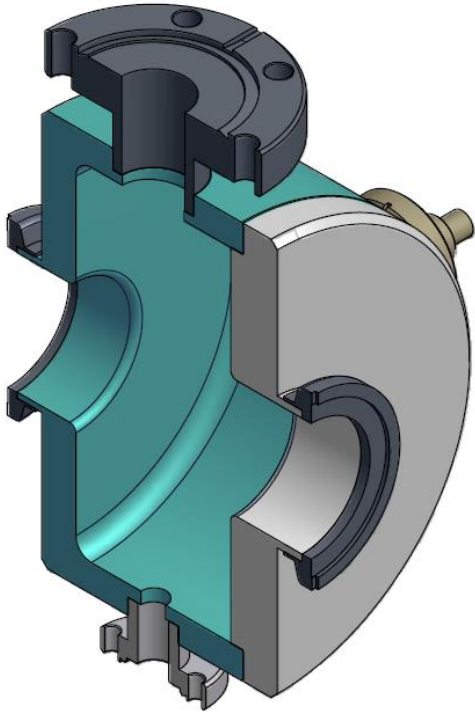
BUNCH ARRIVAL MONITORS

A resonant idle cavity can be placed directly along the LINAC beam trajectory, and a **decaying voltage oscillation** synchronous with the bunch passage can be coupled out of the cavity and demodulated, with no need of photodiodes and RF amplifications.

The bunch arrival monitor cavity is equipped with two tuning plungers. A **manual tuner** will be used for **coarse frequency regulation**, while a motorized **fine tuner** will be remotely controlled to maintain the **coherency between the cavity free oscillations and the reference frequency**.



BUNCH ARRIVAL MONITOR PARAMETERS



TM010 – 2142 MHz

$R/Q \approx 65 \Omega$

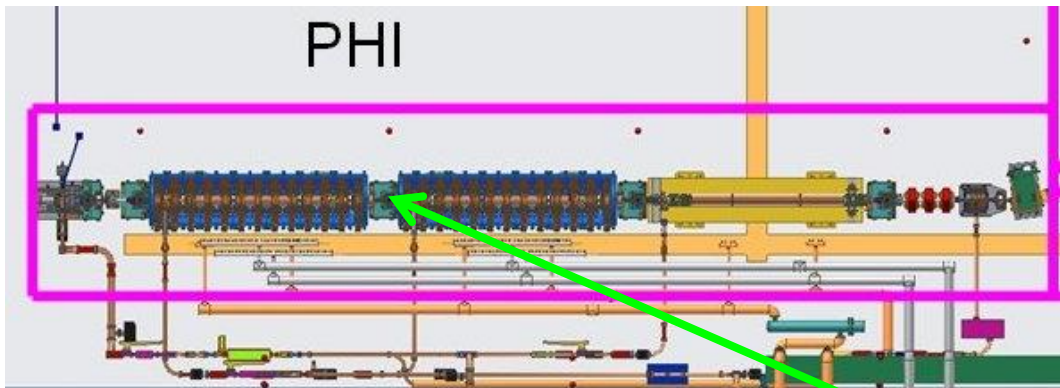
$Q_0 \approx 18000$

$Q_{\text{ext}} = 36000$

V_p (@ 1 nC) = 3.5 V

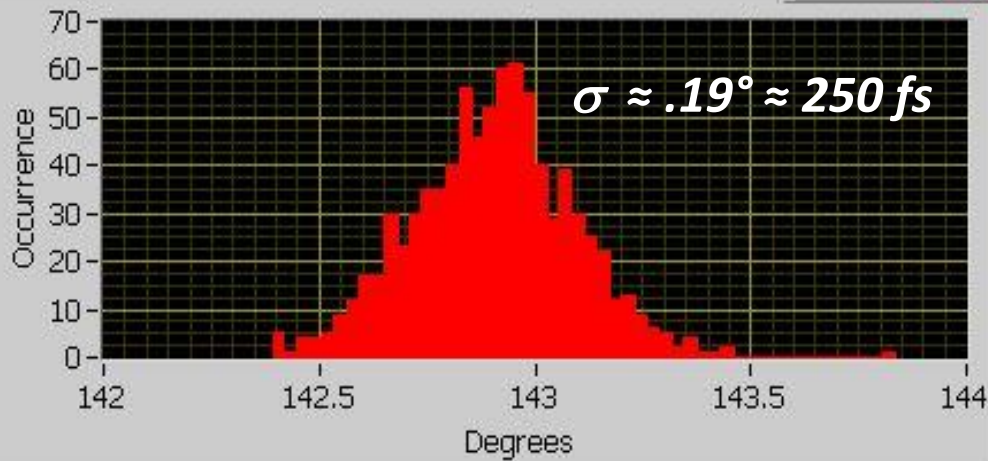
$\Delta f_{\text{tun}} \leq 10 \text{ kHz}$

BUNCH ARRIVAL MONITOR INSTALLATION



PhaseHistogram

Plot 0



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LONGITUDINAL DIAGNOSTICS IN LINAC

Depending on the characteristic scale length, several techniques can be used to measure **electron beam** longitudinal parameters in a LINAC

Time domain

Streak camera: ~ ps down to sub-ps

RF deflecting cavity: ~ ps down to fs scale



Frequency domain

Autocorrelation of coherent radiation emitted by a relativistic bunch: ~ ps down to fs scale

Spectrometers acting on Transition or Diffraction radiation: ~ ps down to sub-ps

Optical methods

Electro-optic sampling which uses the wakefield induced by the beam in a crystal to modulate the field of a laser: **down to few tens of fs**

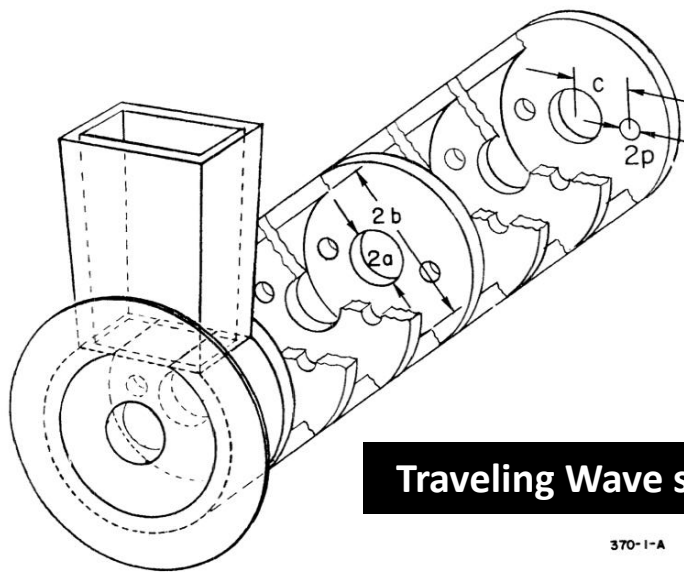
Courtesy of E. Chiadroni

HISTORY

An RF deflecting field can directly streak the electron beam

Deflecting mode cavities were originally invented in the early 1960s as a way to separate different species (masses) of particles in an accelerator

SLAC-PUB-135, Aug. 1965

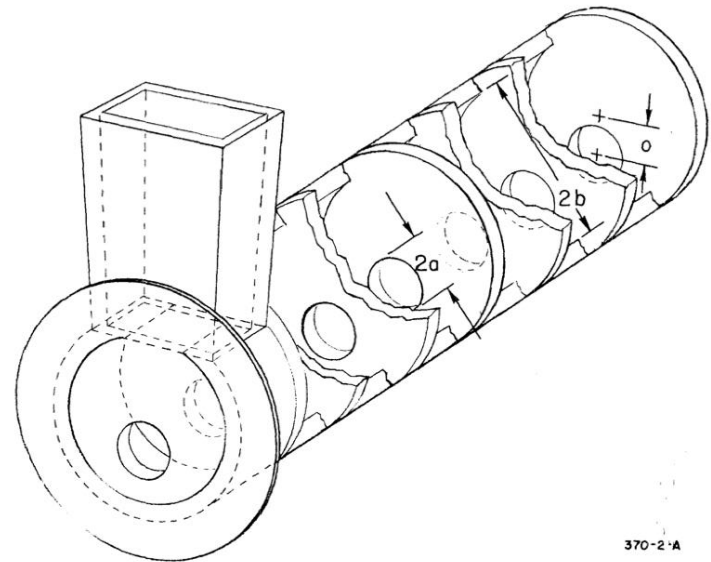


Traveling Wave structures

370-1-A

TM11-type to maximize deflecting efficiency.
The two small lateral holes in the disks are used **to prevent mode rotation**.

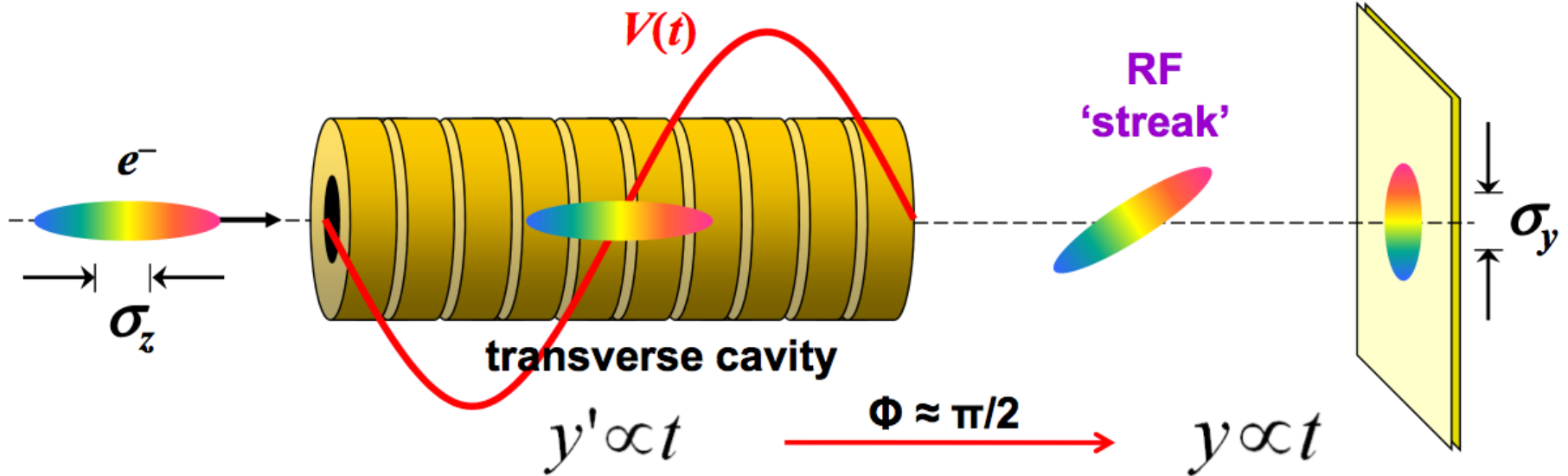
Courtesy of E. Chiadroni



370-2-A

TM01-type by strongly **off-centre iris**.
It has a non-zero longitudinal accelerating or decelerating field on axis.

THE IDEA

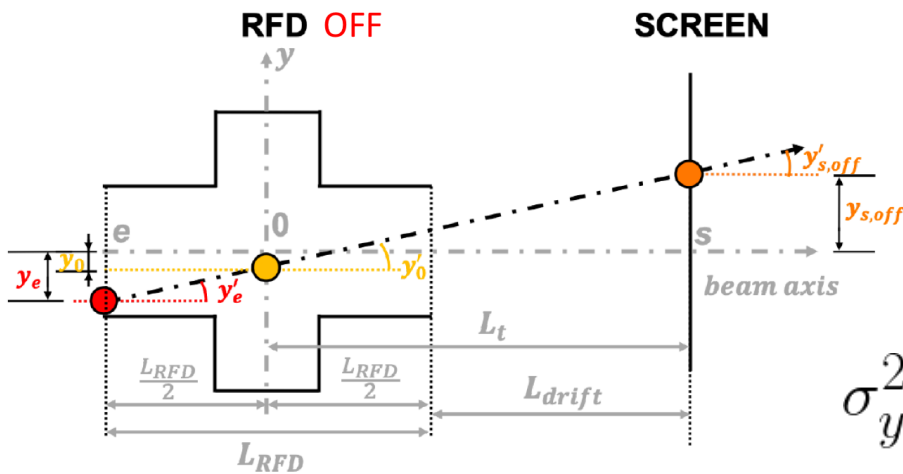
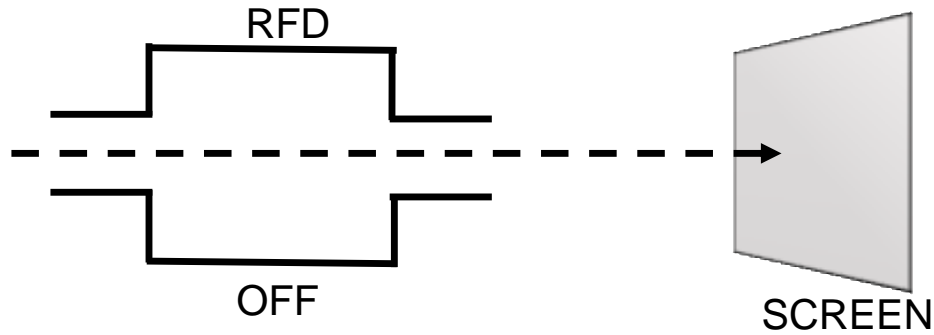


When a beam passes through a **transverse cavity** at the zero-crossing phase, the transverse cavity imprints on the beam a **transverse angular kick** (e.g. in vertical direction) that varies linearly with the longitudinal position. After **90 degrees phase advance**, the angular distribution is converted to spatial distribution, and the vertical axis on some screen downstream of the transverse cavity becomes the time axis.

$V(t)$ is the integrated transverse Lorentz force per unit charge.

Courtesy of E. Chiadroni

PREMISE: RF DEFLECTOR OFF



**Correlations
between spot size
and divergence at
the RFD center**

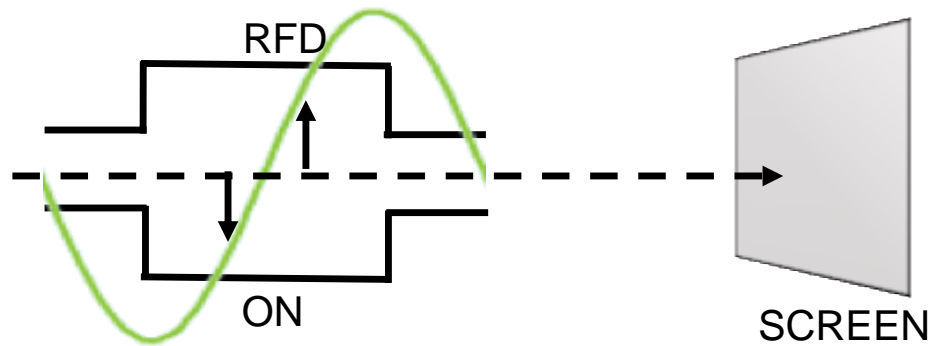
**Divergence at
the RFD center**

$$\sigma_{y_{s,off}}^2 = \sigma_{y_0}^2 + 2L_t\sigma_{y_0y'_0} + L_t^2\sigma_{y'_0}^2$$

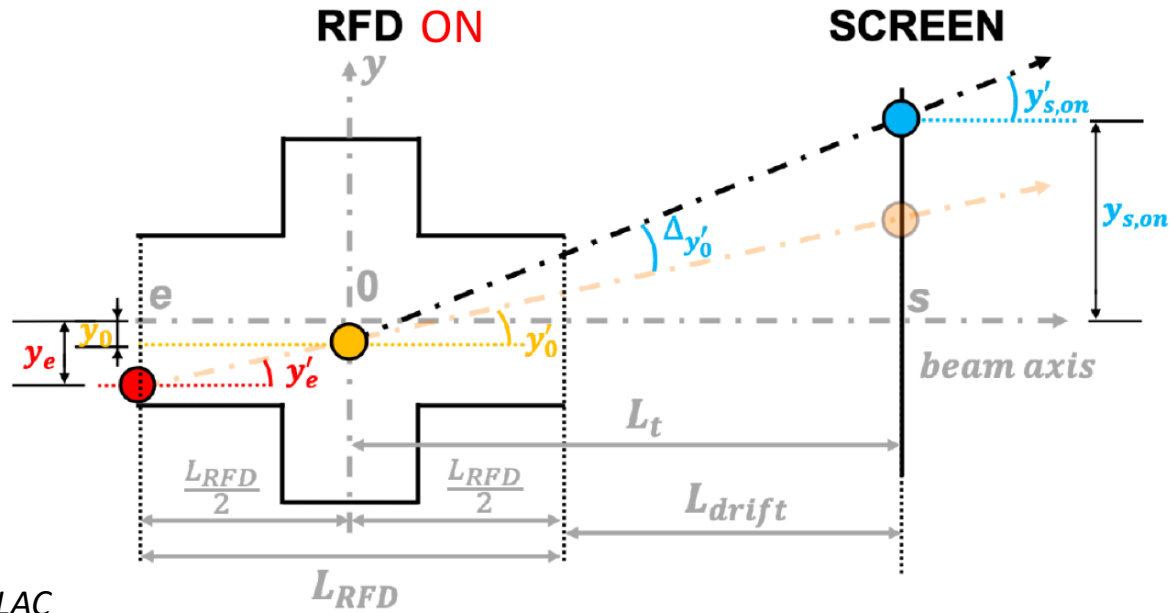
Spot size at the RFD center

Courtesy of A. Gilardi - SLAC

BEAM DEFLECTION



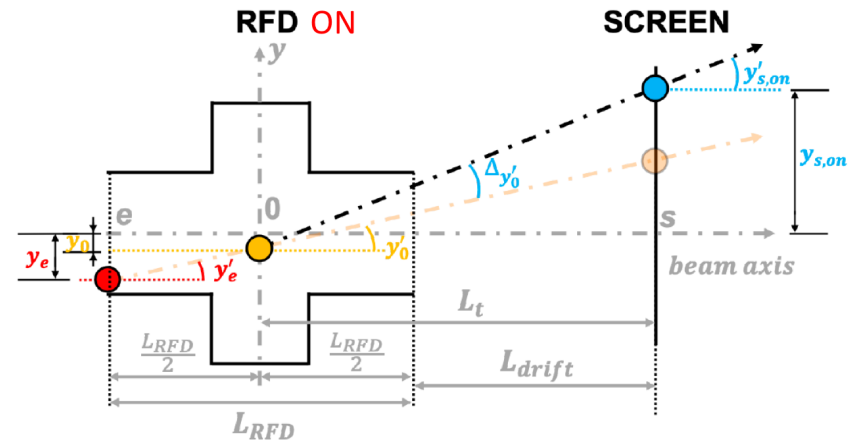
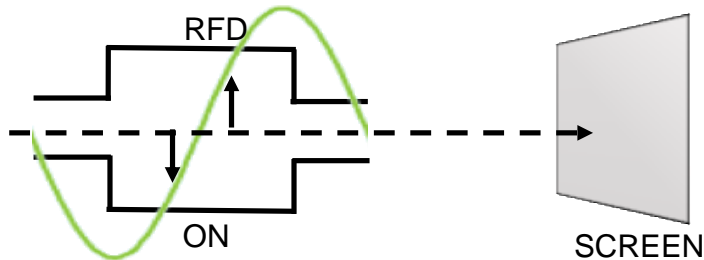
Neglecting the energy spread and energy chirp (correlations between energy and time) contributions.



Courtesy of A. Gilardi - SLAC

BEAM SIZE AFTER DEFLECTION

Courtesy of A. Gilardi - SLAC



Bunch length

Correlation between longitudinal position and transverse position at the RFD center

$$\sigma_{y_{s,on}}^2(\varphi) = \sigma_{y_{s,off}}^2 + K_{cal}^2(\varphi)\sigma_{t_0}^2 + 2K_{cal}(\varphi)\sigma_{y_0 t_0} + 2K_{cal}(\varphi)L_t\sigma_{y'_0 t_0}$$

Spot size with RFD off

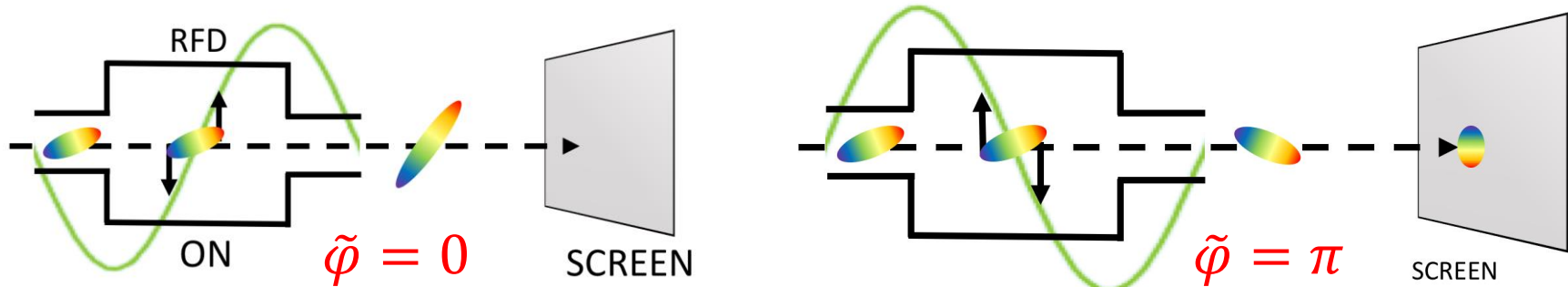
Calibration factors related with RFD characteristics

Correlation between longitudinal position and transverse divergence at the RFD center

BUNCH LENGTH MEASUREMENT

Cancel correlations between longitudinal position and transverse position/divergence

$$\sigma_{y_{s,on}}^2(\varphi) = \sigma_{y_{s,off}}^2 + K_{cal}^2(\varphi)\sigma_{t_0}^2 + 2K_{cal}(\varphi)\sigma_{y_0 t_0} + 2K_{cal}(\varphi)L_t\sigma_{y'_0 t_0}$$



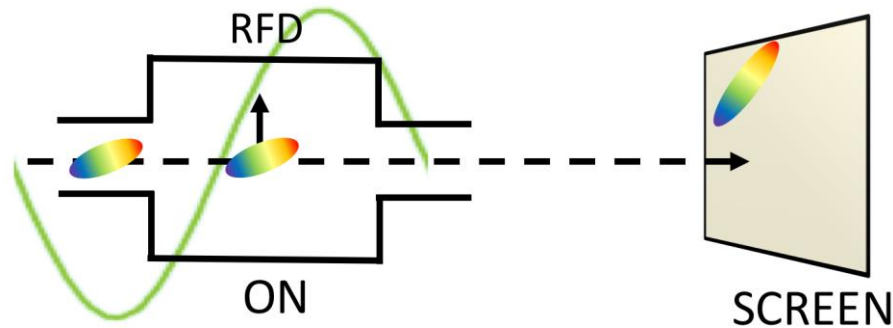
$$\overline{\sigma_{y_{s,on}}^2}(\varphi) = \frac{\sigma_{y_{s,on}}^2(\varphi) + \sigma_{y_{s,on}}^2(\varphi + \pi)}{2} = \sigma_{y_{s,off}}^2 + K_{cal}^2(\varphi)\sigma_{t_0}^2$$

$$\sigma_{t_0} = \frac{\sqrt{\sigma_{y_{s,on}}^2 - \sigma_{y_{s,off}}^2}}{|K_{cal}(\varphi)|}$$

$$K_{cal}(\varphi) = 2\pi f_{RF} \frac{eV_{defl}}{E_{beam}} L_t \cos\varphi$$

Courtesy of A. Gilardi - SLAC

SELF-CALIBRATION



$$\sigma_{t_0} = \frac{\sqrt{\sigma_{y_s,on}^2 - \sigma_{y_s,off}^2}}{|K_{cal}(\varphi)|}$$

$$K_{cal}(\varphi) = 2\pi f_{RF} \frac{eV_{defl}}{E_{beam}} L_t \cos\varphi$$

At phases different from 0, the centroid is deflected. By measuring the deflection of the centroids one can derive the calibration constant.

The measurement is **self-calibrated**, meaning that the constant can be measured independently by the measurement of the beam energy or the deflecting voltage.

RESOLUTION LIMIT

The resolution limit is typically assumed when **the deflected spot size equals the undeflected beam size.**

$$\sigma_t^{res} = \frac{E_{beam}}{eV_0} \frac{1}{L_t} \frac{1}{2\pi f_{RF}} \sigma_{y,off}$$

Maximum deflecting voltage available

Focusing system is set to have the **minimum spot size of the undeflected beam** (it results in the best phase advance between the deflector and the screen).

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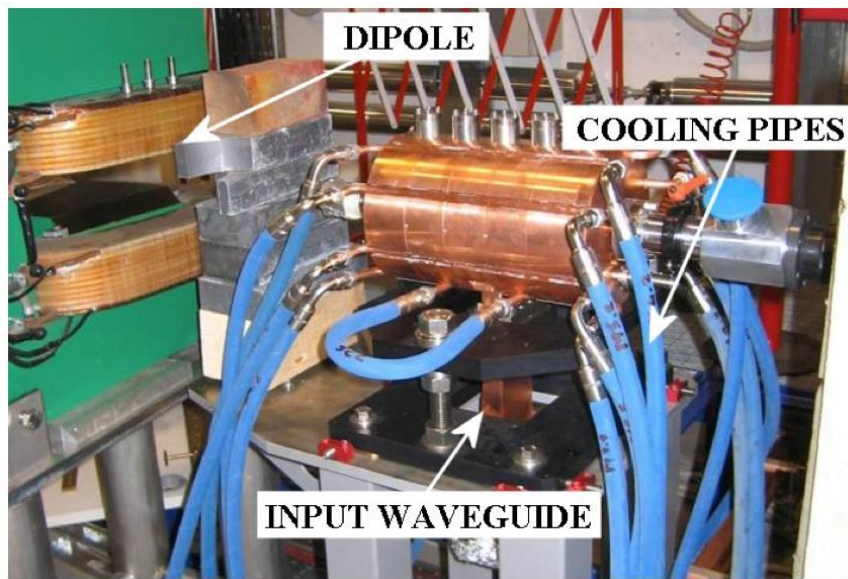
Novel ideas

EXAMPLES OF RF DEFLECTORS

SPARC@LNF-INF

5-cell **Standing Wave**

operating on the π mode at 2.856 GHz



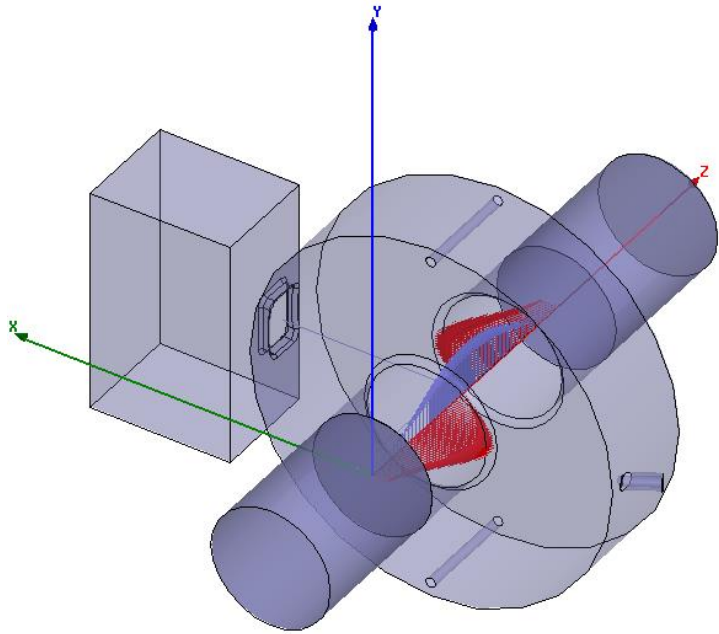
LOLA@FLASH

Traveling Wave

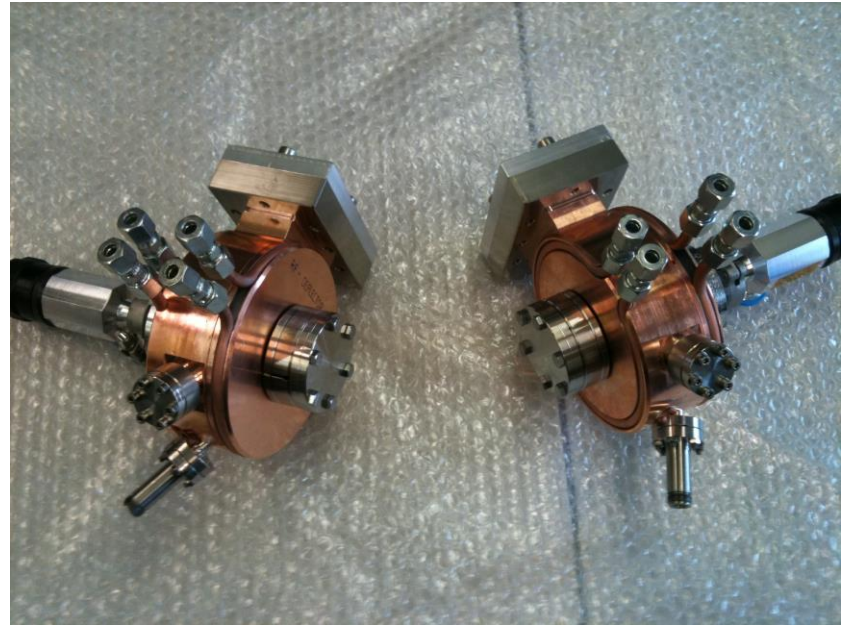
operating at $2\pi/3$ at 2.856 GHz



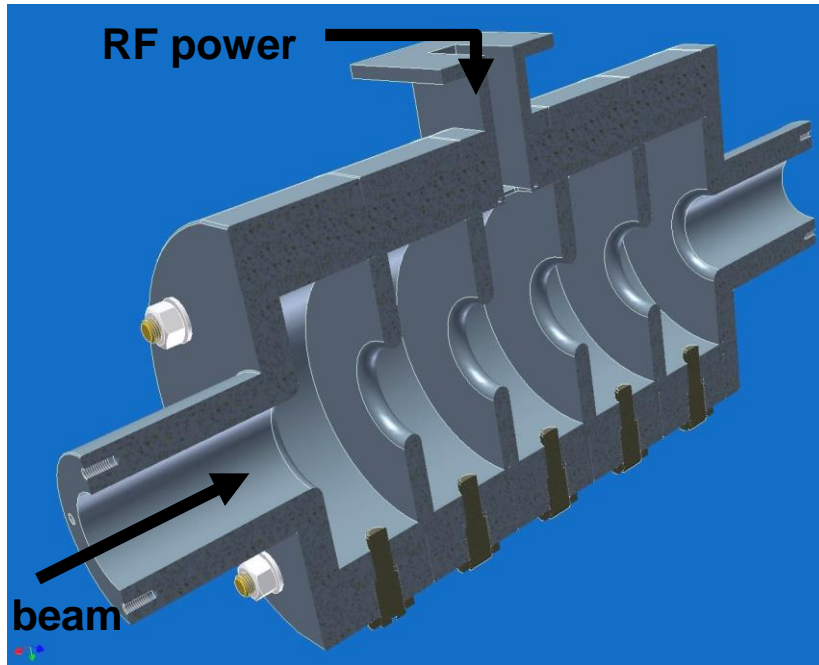
EXAMPLES OF RF DEFLECTORS - 2



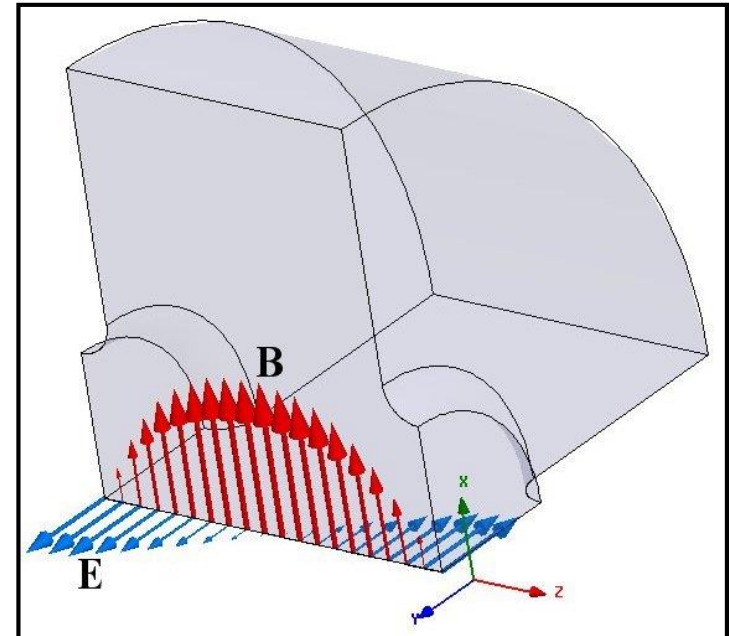
TM110-like mode



SPARC STANDING WAVE RF DEFLECTOR



TM₁₁₀-like mode

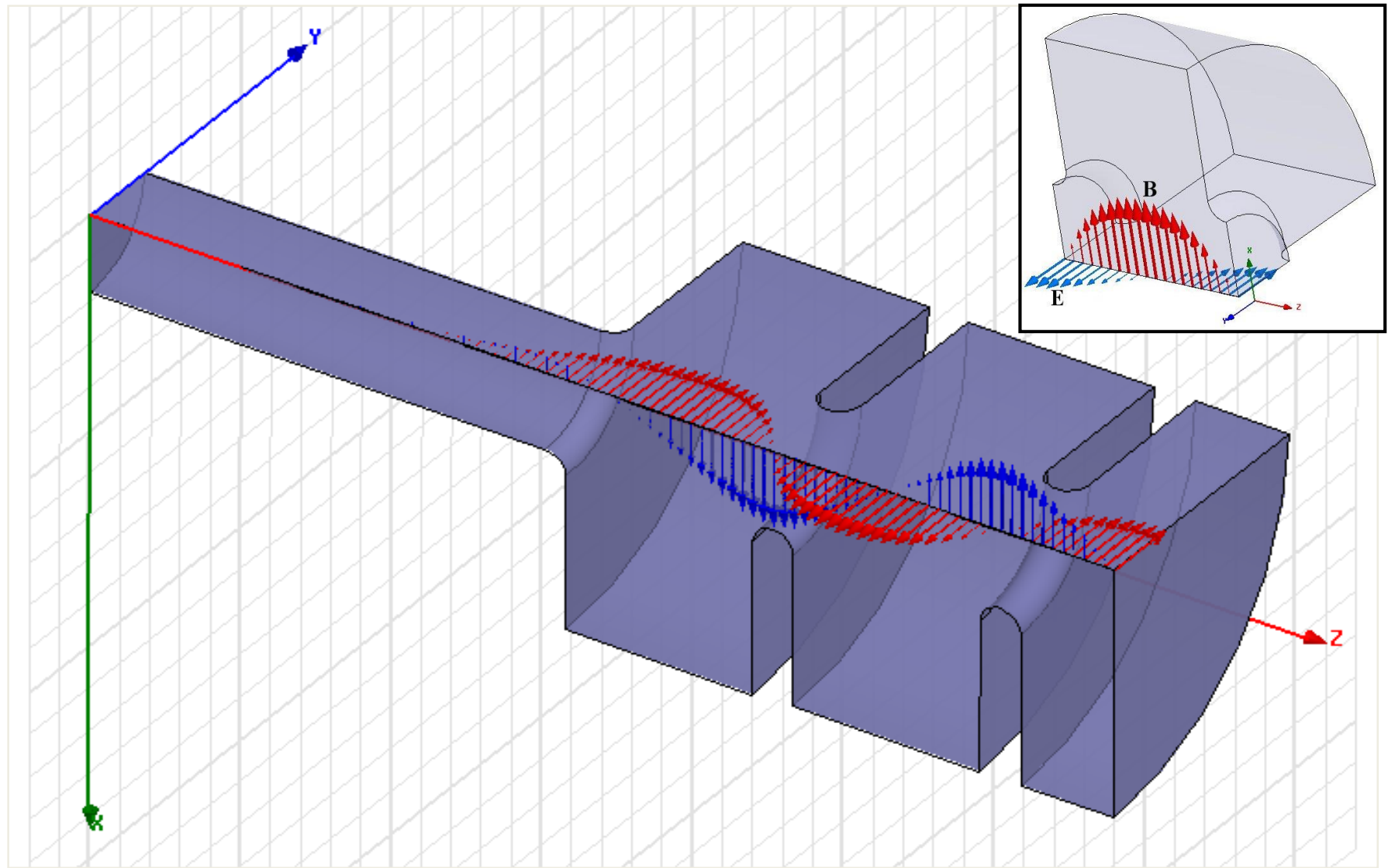


Res. freq.: 2.856 GHz

$Q_{\text{ext}} = 14000$ $Q_0 = 14000$

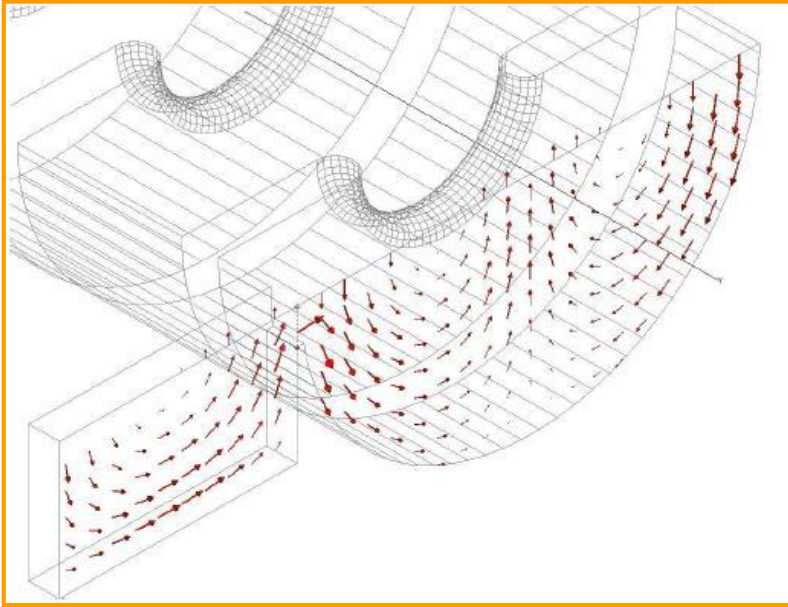


TM110-LIKE MODE FIELD PATTERN

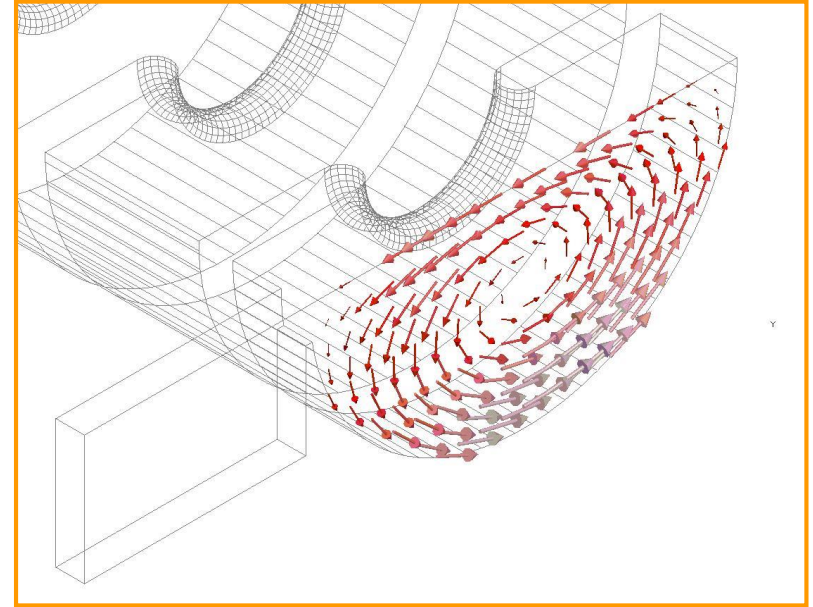


CILINDRICAL SYMMETRY

Cylindrical symmetry is a problem for deflecting structures



Working polarisation



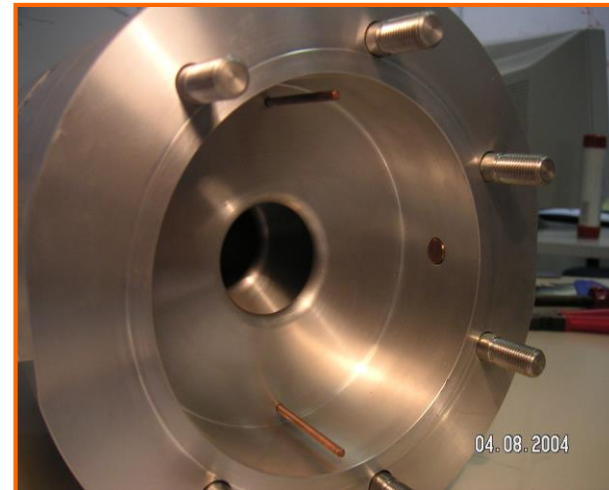
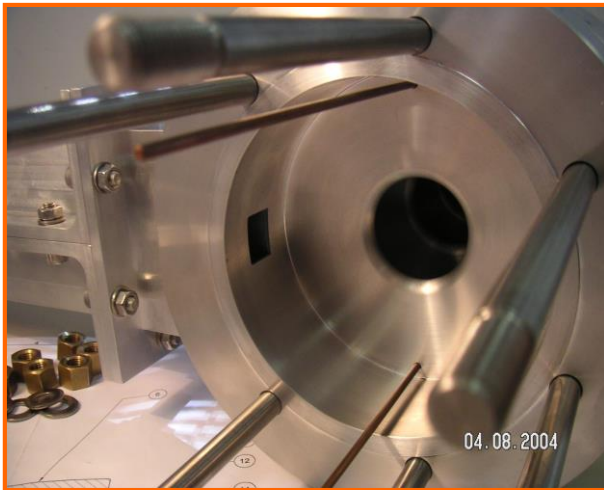
Orthogonal polarisation

TUNING RODS

Cylindrical symmetry is a problem for deflecting structures

Detune one of the polarisations.

Slater theorem can be used.

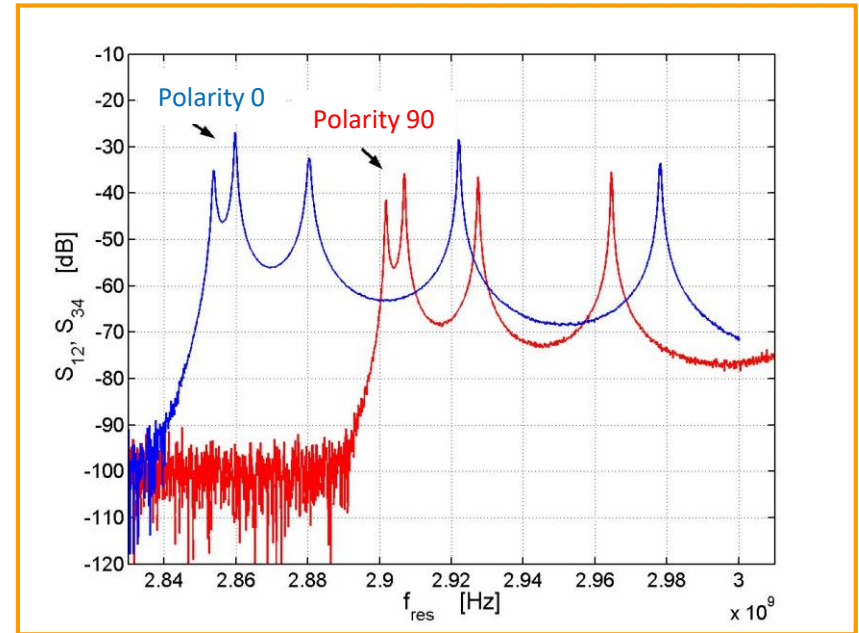
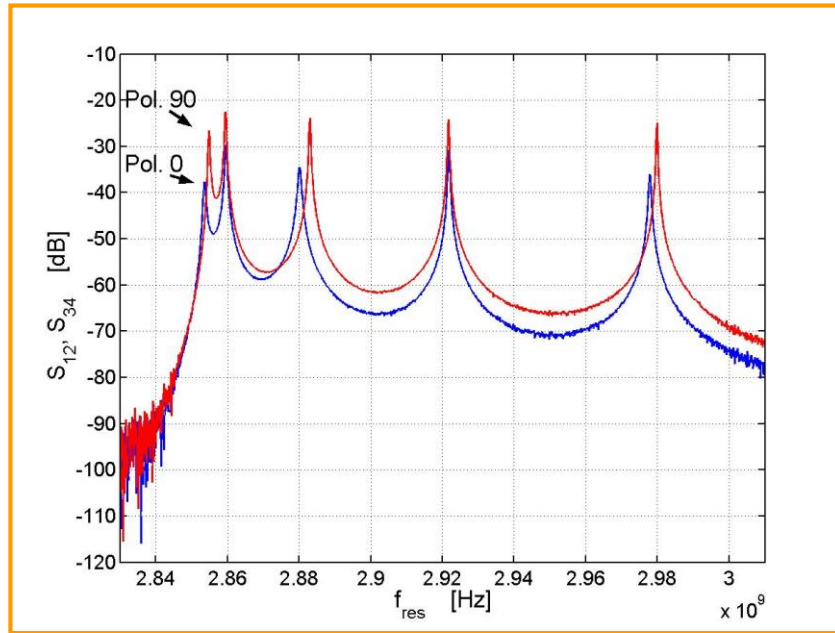


TUNING RODS

Cylindrical symmetry is a problem for deflecting structures

Detune one of the polarisations.

Slater theorem can be used.



BEAD PULL MEASUREMENT

Field measurement inside the cavity: bead-pull technique.

The perturbation Δf of the resonant frequency f_0 depends on the field in the position of the **small** (dielectric or metallic) perturbing object (W being the energy stored in the cavity).

Slater theorem

Dielectric beads $\left(\frac{\Delta f}{f_0}\right)_{diel} \simeq k_{Ed}\epsilon_0 \frac{|\vec{E}|^2}{W}$

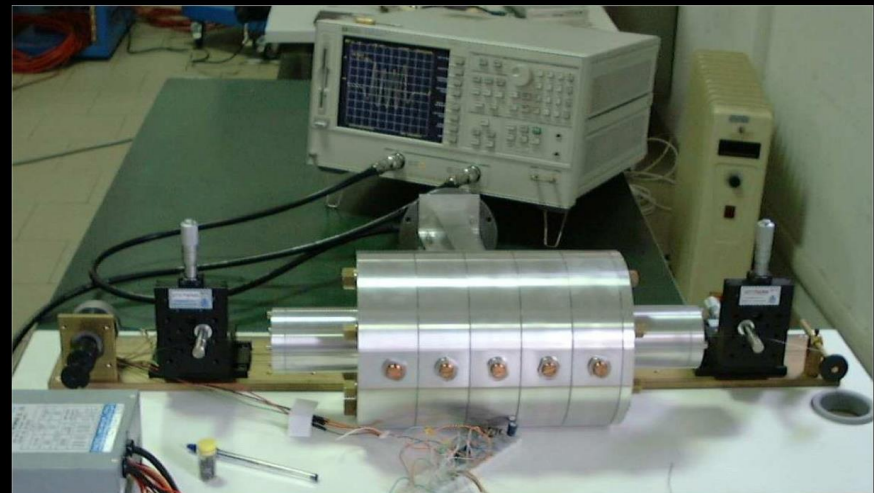
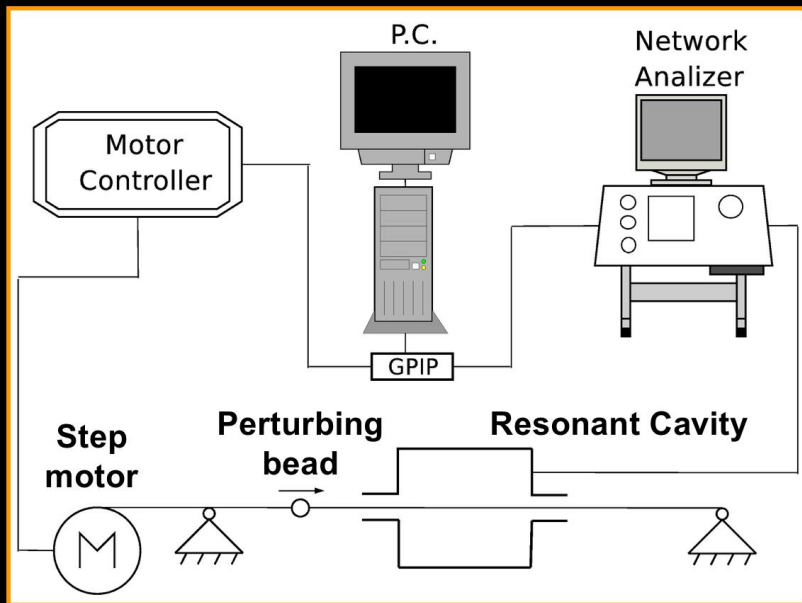
Metallic beads $\left(\frac{\Delta f}{f_0}\right)_{met} \simeq k_{Em}\epsilon_0 \frac{|\vec{E}|^2}{W} - k_{Bm}\mu_0 \frac{|\vec{B}|^2}{W}$

$$\frac{|\vec{B}|^2}{W} \simeq \frac{1}{k_{Bm}\mu_0} \left[\left(\frac{\Delta f}{f_0}\right)_{met} + \frac{k_{Em}}{k_{Ed}} \left(\frac{\Delta f}{f_0}\right)_{diel} \right]$$

Measurement

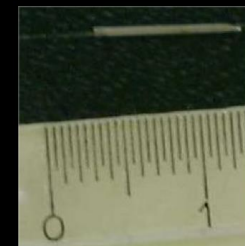
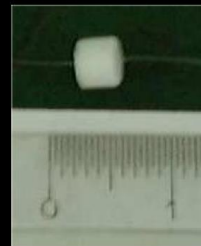
Calibration

MEASUREMENT SET-UP



Perturbing beads

$$\frac{\Delta f(z)}{f_0} \simeq \frac{1}{2Q_L} \tan(\angle S_{12}(z))$$



BEAD CALIBRATION



Copper brazed pill-box cavity

$$\left(\frac{\Delta f}{f_0}\right)_{met} \simeq k_{Em}\epsilon_0 \frac{|\vec{E}|^2}{W} - k_{Bm}\mu_0 \frac{|\vec{B}|^2}{W}$$

$$\left(\frac{\Delta f}{f_0}\right)_{diel} \simeq k_{Ed}\epsilon_0 \frac{|\vec{E}|^2}{W}$$

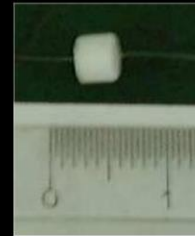
Measurement

Simulation/Theory

TM₀₁₀ Only E_z field on axis

TM₁₁₀ Only B_⊥ field on axis

TE₁₁₁ Only E_⊥ field at the center



Dielectric cylinder

$$\text{TE}_{111} \longrightarrow k_{Ed}$$



Metallic sphere

$$\text{TM}_{110} \longrightarrow k_{Bm}$$

$$\text{TE}_{111} \longrightarrow k_{Em}$$



Metallic needle

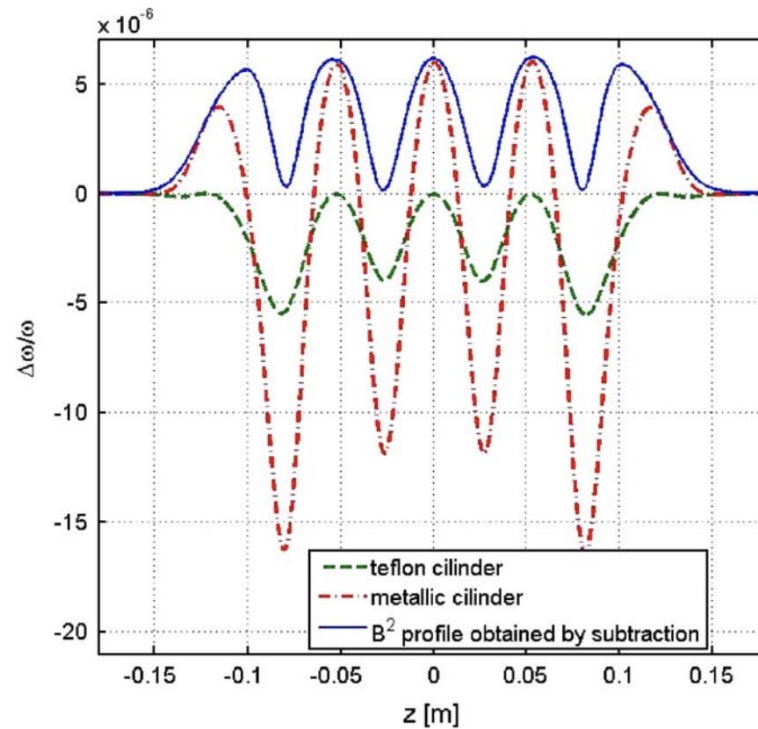
$$\text{TM}_{010} \longrightarrow k_{Em}$$

COMBINING MEASUREMENTS

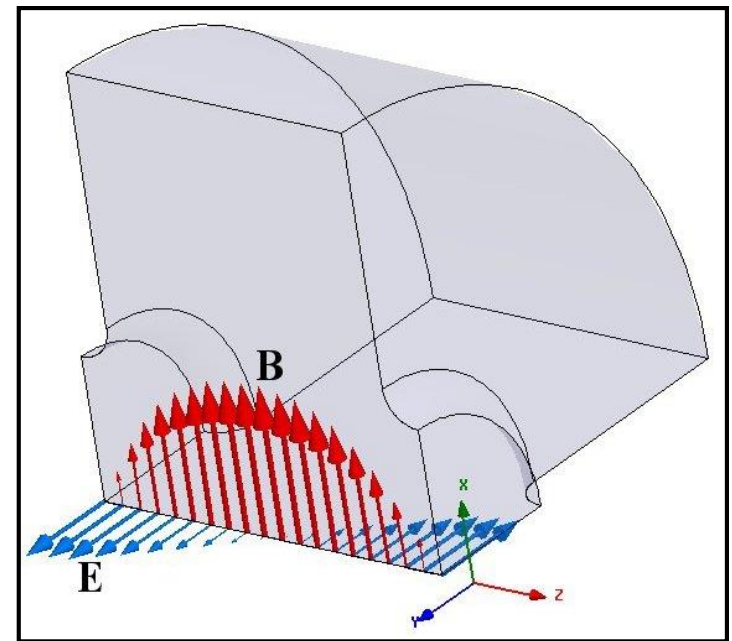
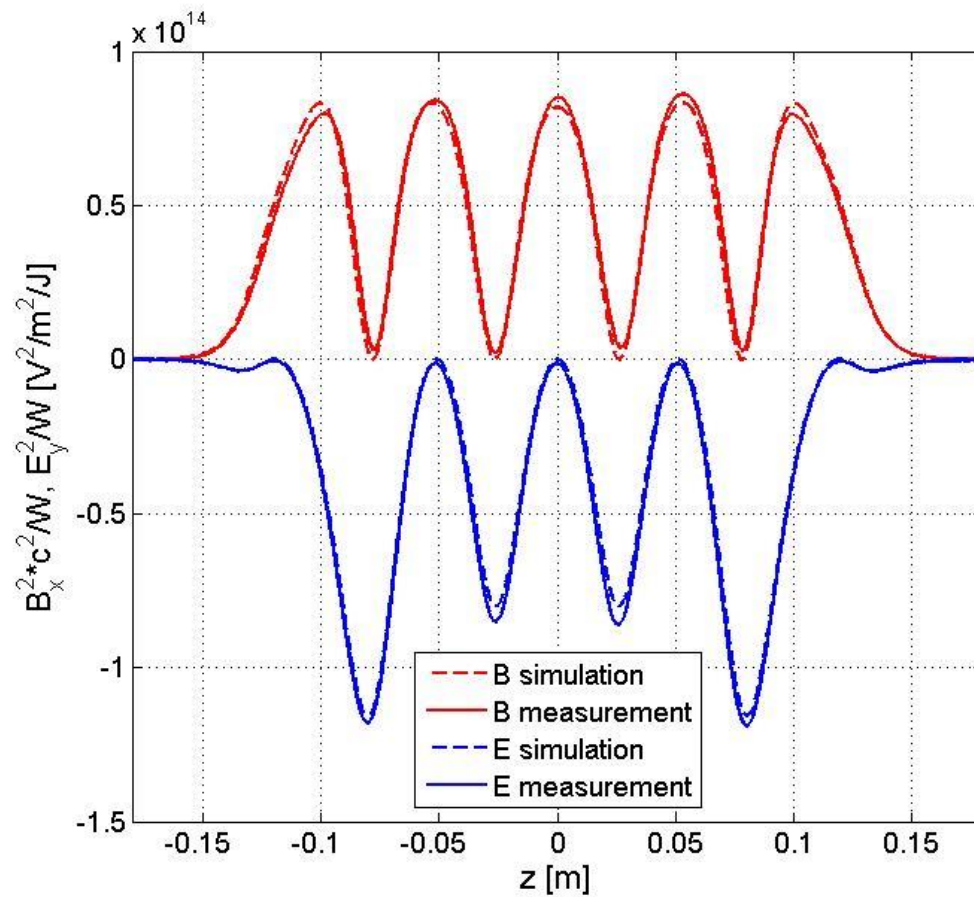
$$\frac{|\vec{B}|^2}{W} \simeq \frac{1}{k_{Bm}\mu_0} \left[\left(\frac{\Delta f}{f_0} \right)_{met} + \frac{k_{Em}}{k_{Ed}} \left(\frac{\Delta f}{f_0} \right)_{diel} \right]$$

Measurement

Calibration



FIELD MEASUREMENT



OUTLINE

Longitudinal diagnostics

Bunch arrival monitor (passive cavity)

Bunch length diagnostics

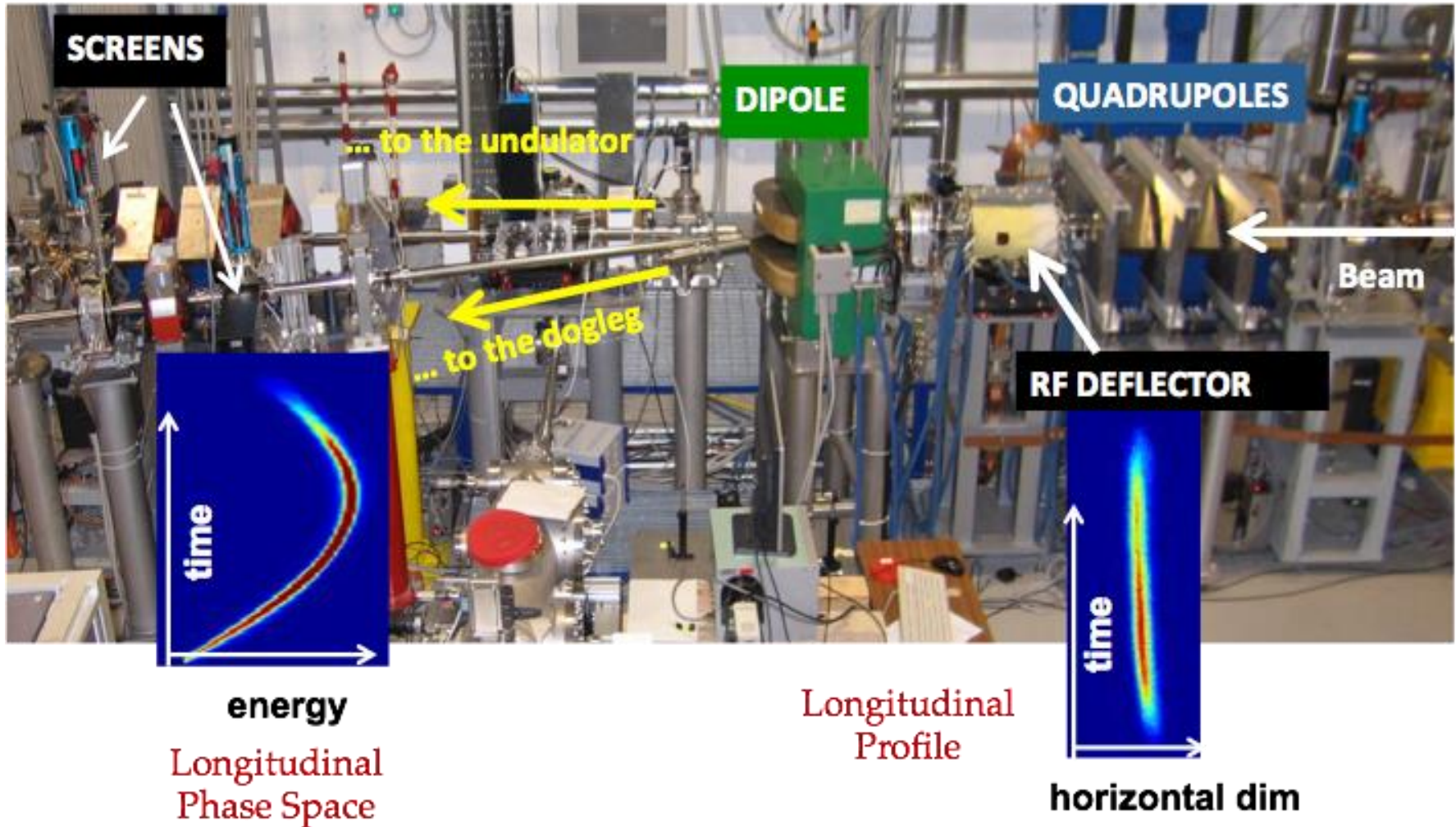
RF deflector for bunch length measurement

Design of the structure and realisation issue

Beam measurement and calibration

Novel ideas

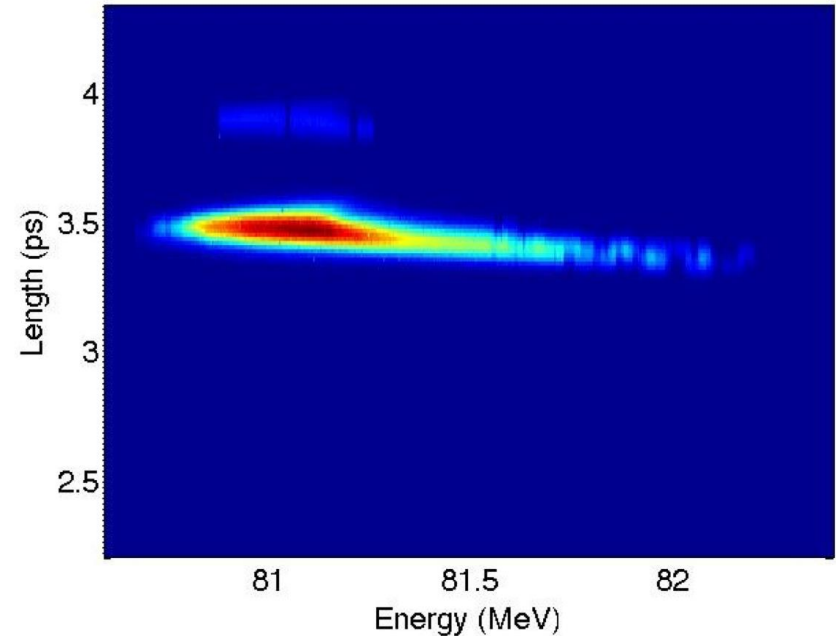
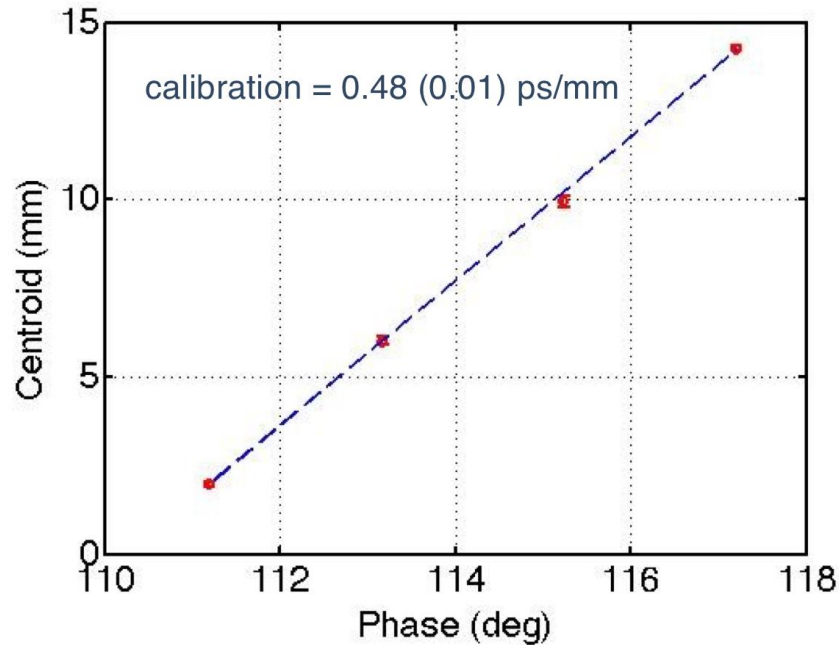
LONGITUDINAL PHASE SPACE MEASUREMENT



Courtesy of E. Chiadroni

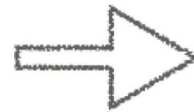
CALIBRATION AND LENGTH MEASUREMENT

SPARC@LNF-INFN



$$\sigma_{ys} = 70 \text{ fs}$$

$$\sigma_{yB} \cdot \text{calibration} = 45 \text{ fs}$$



$$\sigma_t = 50 \text{ fs}$$

Courtesy of E. Chiadroni

BUNCH TRAIN - LONGITUDINAL PHASE SPACE

SPARC@LNF-INFN

Measurements with 200pC

Gun energy 5.7MeV

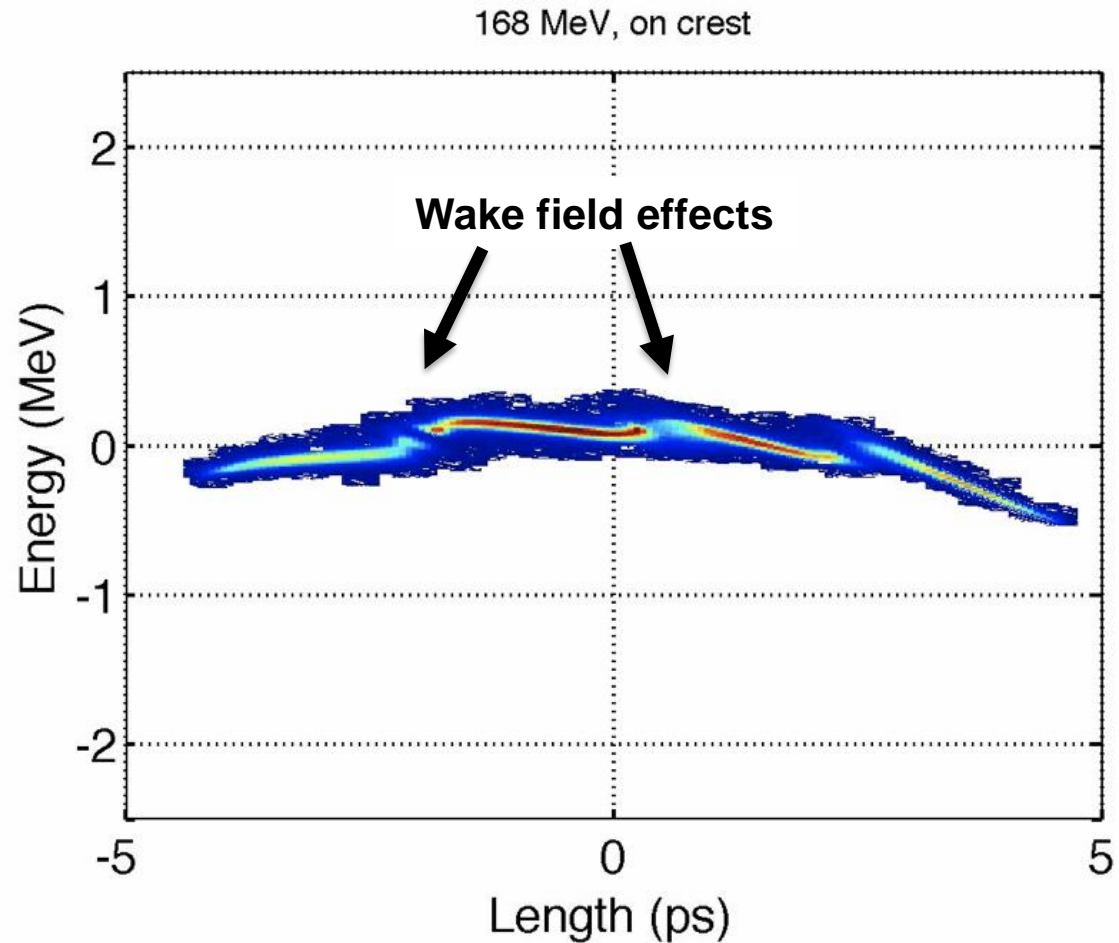
Charge
40pC/80pC/50pC/30pC

Energy 168 MeV

Energy Spread <0.8%

Bunch length on crest
2.1263 (0.0087) ps

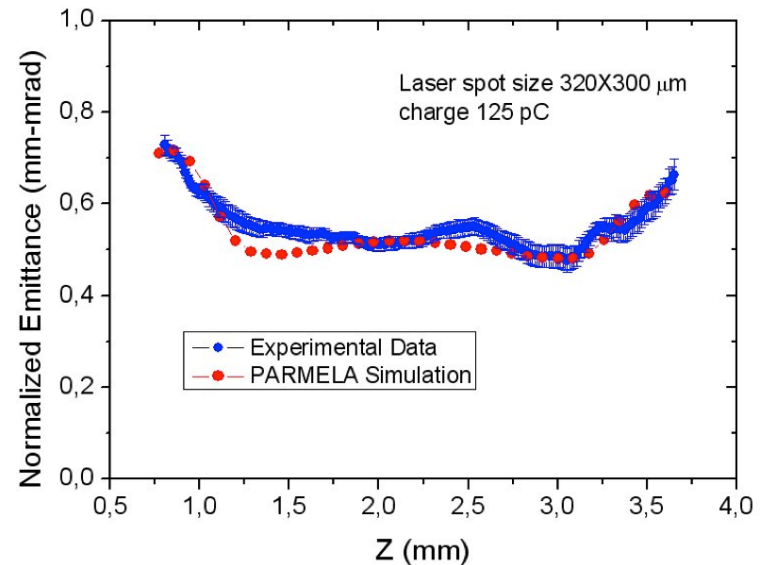
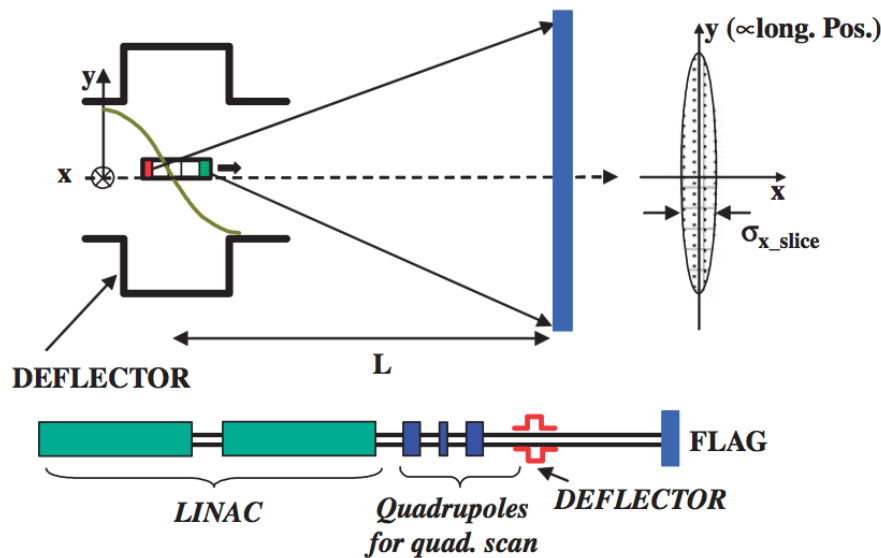
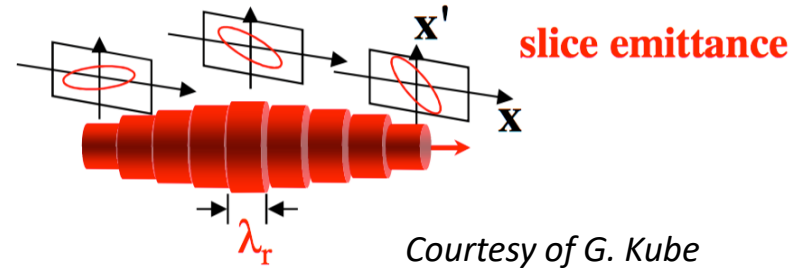
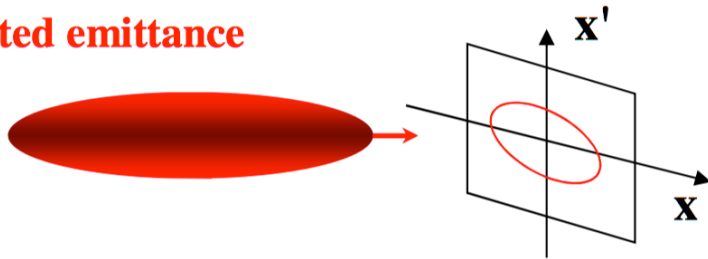
Gun ext. phase
35 deg



TIME RESOLVED MEASUREMENT

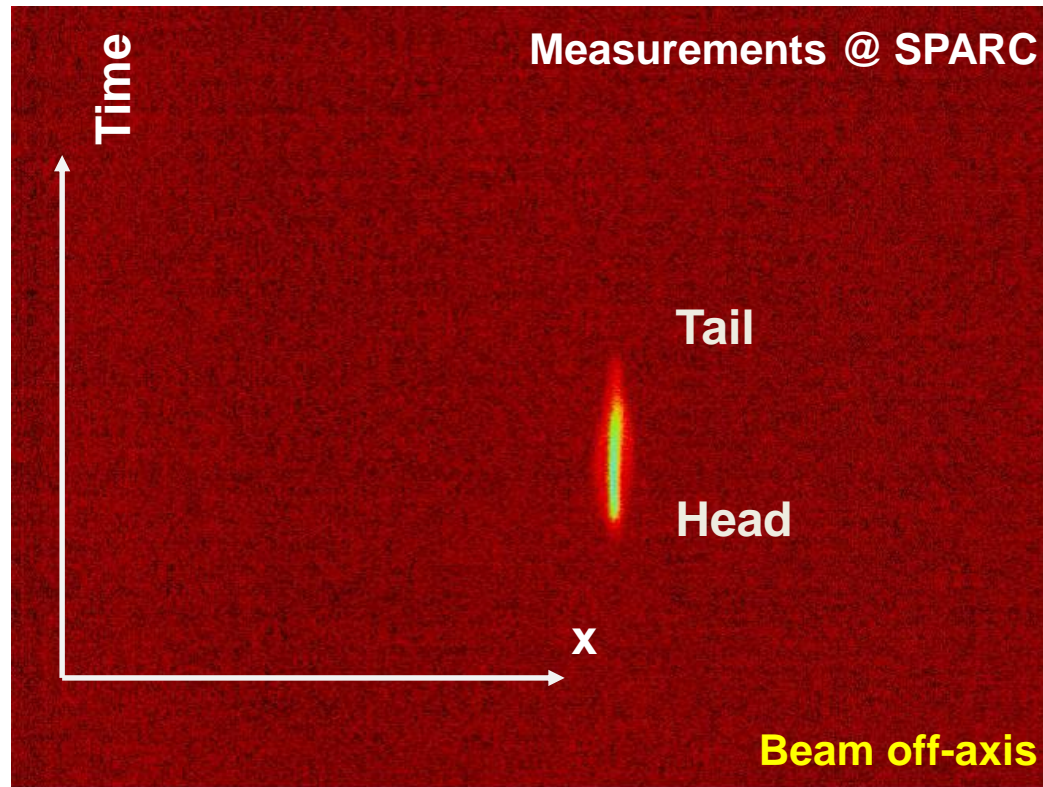
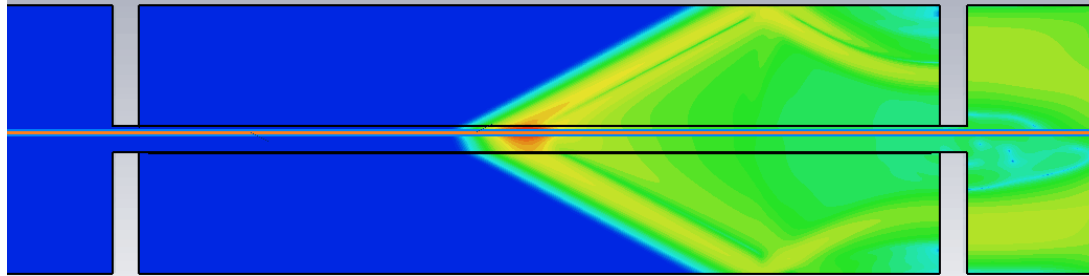
Combined with a **quadrupole scan** technique, RFD allows for the measurement of the **slice emittance** on the plane orthogonal to the streaking direction

projected emittance



ELECTRON BEAM IN DIELECTRIC CAPILLARY

Wakefield
simulations



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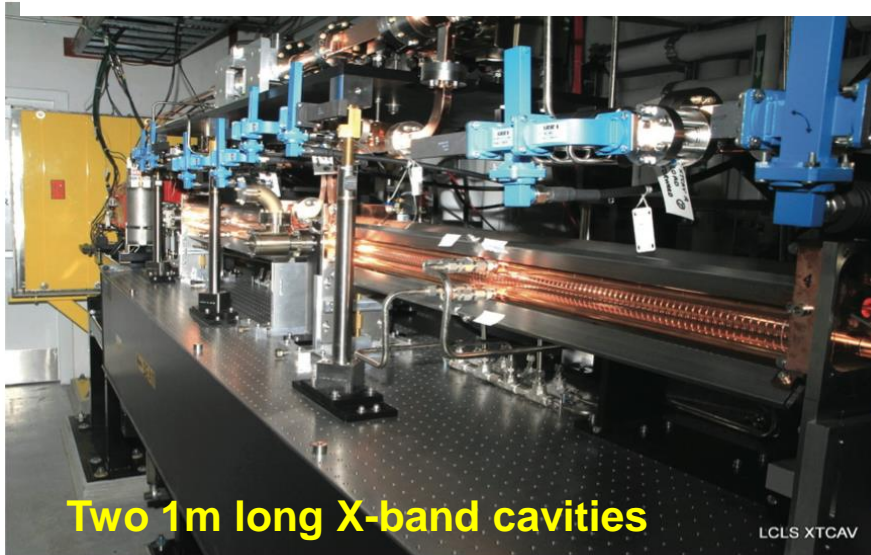
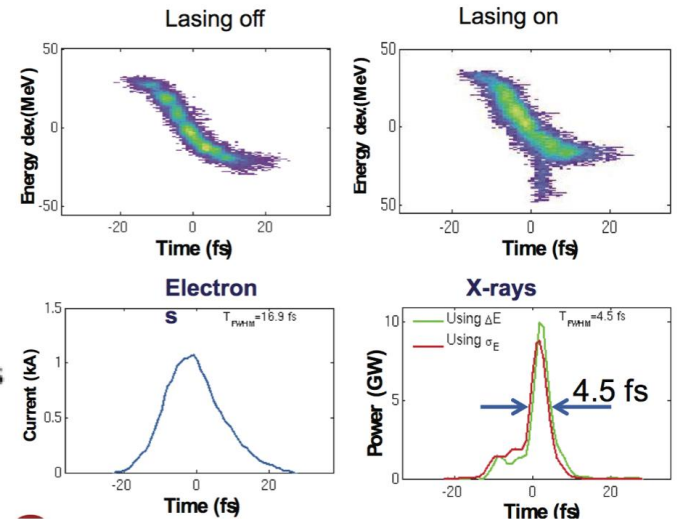
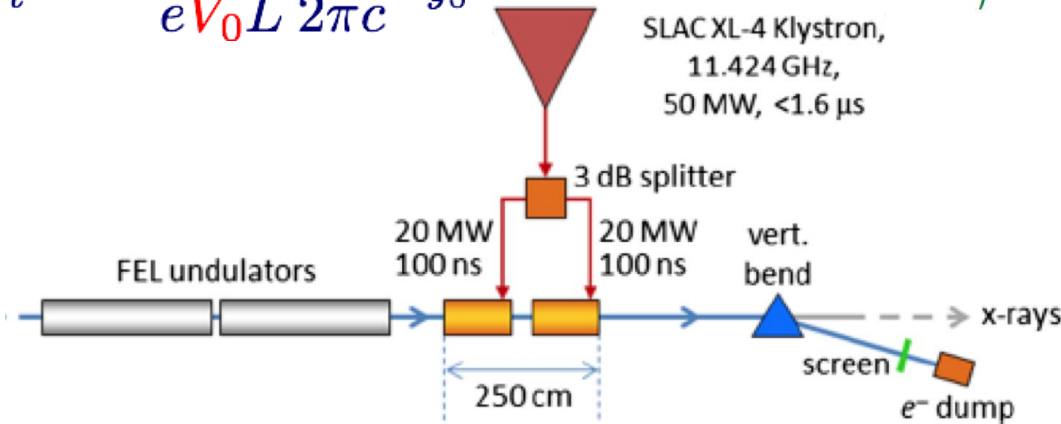
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Novel ideas

RFD CAVITY FOR FS-SCALE BEAM (1)

$$\sigma_t^{res} = \frac{E}{eV_0 L} \frac{\lambda}{2\pi c} \sigma_{y0}$$



X-band TCAV

Frequency

11.424 GHz

Max kick

48 MV @ 40 MW

Temporal resolution

14 GeV

4.3 GeV

3 fs

1 fs

RFD CAVITY FOR FS-SCALE BEAM (2)

- X-band TDS enabled \sim sub-fs temporal resolution
- TDS after undulator section at LCLS:
 - daily tuning of FEL operation
 - online single-shot FEL pulse characterization

Direct Measurement of Sub-10 fs Relativistic Electron Beams with Ultralow Emittance

Jared Maxson,^{*} David Cesar, Giacomo Calmasini, Alexander Ody, and Pietro Musumeci
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(Received 5 November 2016; published 12 April 2017)

Proceedings of IPAC2017, Copenhagen, Denmark

HIGH POWER TEST OF SINAP X-BAND DEFLECTOR AT KEK

Jianhao Tan, Dechun Tong, Qiang Gu, Wencheng Fang, Xiaoxia Huang, Zongbin Li, Toshiyasu Higo, Zhenfeng Zhao^{*}

RF design of X-band RF deflector for femtosecond diagnostics of LCLS electron beam

Cite as: AIP Conference Proceedings 1507, 682 (2012); <https://doi.org/10.1063/1.4773780>
Published Online: 21 December 2012

Valery A. Dolgashev, and Juwen Wang

MOPE094

Proceedings of IPAC'10, Kyoto, Japan

X-BAND TRAVELLING WAVE DEFLECTOR FOR ULTRA-FAST BEAM DIAGNOSTICS^{*}

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ARTICLE

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Few-femtosecond time-resolved measurements of X-ray free-electron lasers

C. Behrens^{1,2}, F.-J. Decker¹, Y. Ding¹, V.A. Dolgashev¹, J. Frisch¹, Z. Huang¹, P. Krejčík¹, H. Loos¹, A. Lutman¹, T.J. Maxwell¹, J. Turner¹, J. Wang¹, M.-H. Wang¹, J. Welch¹ & J. Wu¹

PHYSICAL REVIEW SPECIAL TOPICS - ACCELERATORS AND BEAMS 17, 102801 (2014)

Design and application of multimegawatt X-band deflectors for femtosecond electron beam diagnostics

Valery A. Dolgashev,^{*} Gordon Bowden, Yuanfeng Ding, Paul Emma, Patrick Krejčík, James Lewandowski, Cecile Limborg, Michael Litos, Juwen Wang, and Dao Xiang
SLAC National Accelerator Laboratory, Menlo Park, California 94025, USA
(Received 3 December 2013; revised manuscript received 12 August 2014; published 2 October 2014)

PHYSICAL REVIEW SPECIAL TOPICS - ACCELERATORS AND BEAMS 14, 120701 (2011)

Femtosecond x-ray pulse temporal characterization in free-electron lasers using a transverse deflector

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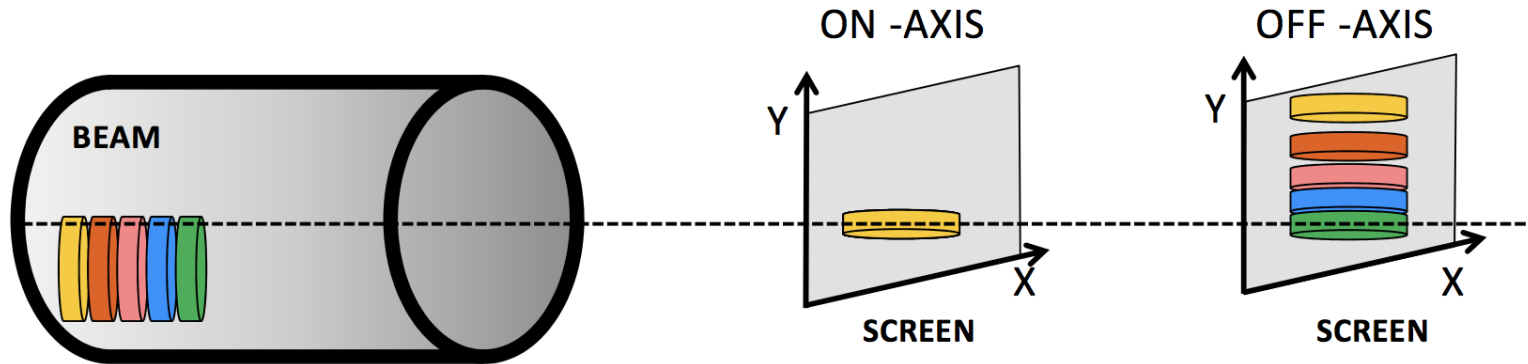
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PASSIVE STREAKER WORKING PRINCIPLE

Courtesy of S. Bettoni- PSI



- ❑ The method to time-resolve the longitudinal profile is based on the self-transverse-wakefield generation
- ❑ A correlation between temporal position of the particle along the bunch and transverse position at a downstream screen is introduced
- ❑ The beam passes off-axis through a structure capable of generating a strong monotonic transverse wakefield along the full bunch length
- ❑ Cylindrical or planar, corrugated or dielectric-lined geometries may be used without altering the principle
- ❑ Potentially sub-fs resolutions achievable

S. Bettoni et al., **Passive Streaking Using Transverse Wakefield for Ultrashort Bunch Diagnostics** , IPAC 2017

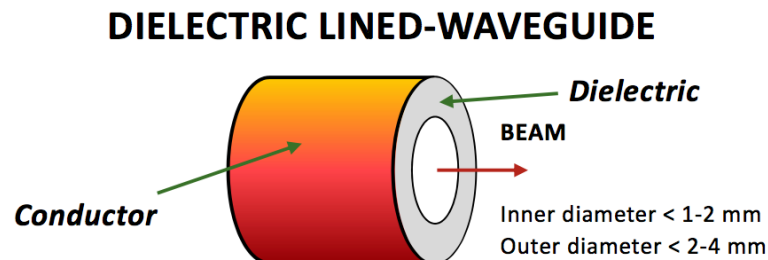
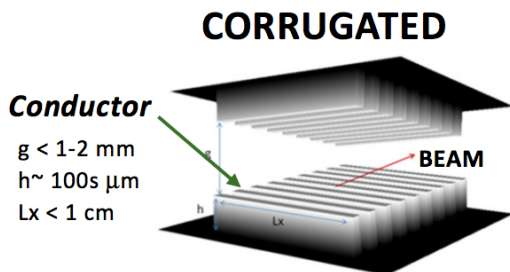
PASSIVE STREAKER WORKING PRINCIPLE

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Several sources can be used to do such a measurements.

The requirements are:

- Function monotone along the full bunch length
- Amplitude of the wakefield enough to limit the length of the device to a reasonable value (~few meters)

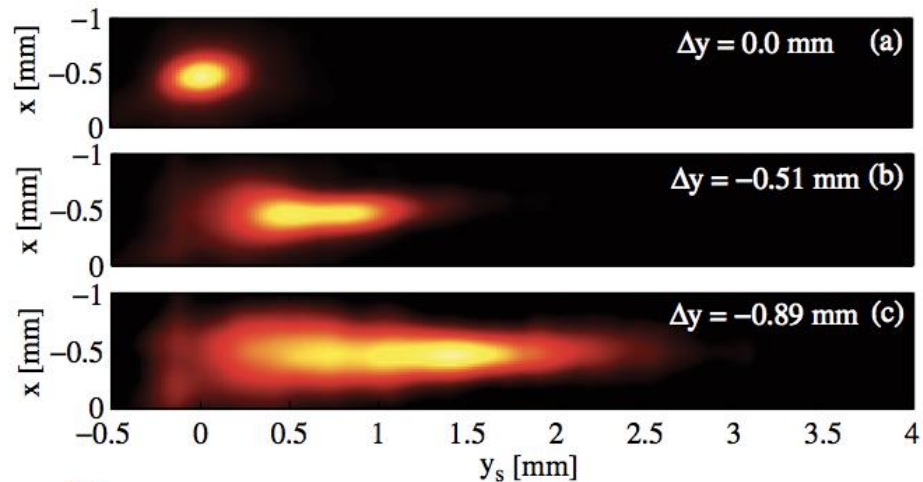
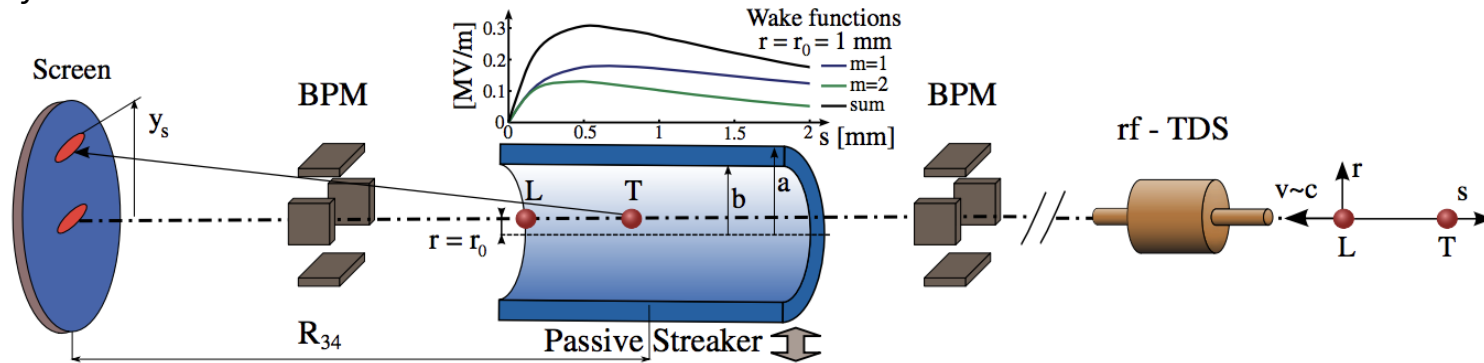


	Flat	Round	
More typically corrugated →	Easily tunable	More difficult to tune	← More typically dielectric lined
	Reduced amplitude (by $\pi^2/16$)	Maximum amplitude	

S. Bettoni et al., **Passive Streaking Using Transverse Wakefield for Ultrashort Bunch Diagnostics** , IPAC 2017

PASSIVE STREAKER EXPERIMENT@PSI

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S. Bettoni et al., Temporal profile measurements of relativistic electron bunch based on wakefield generation, PRAB 19, 021304 (2016)

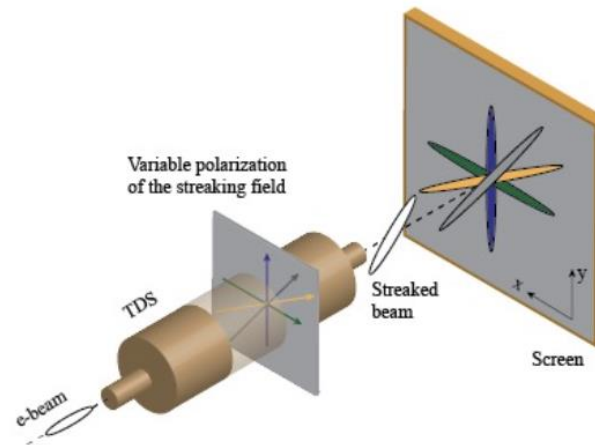
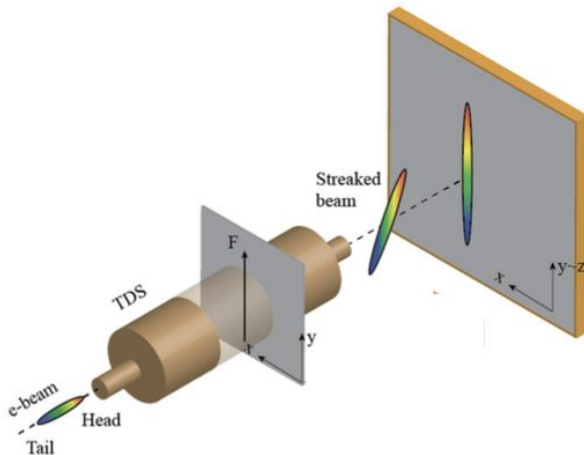
THE POLARIX

Courtesy of P. Craievich - PSI

TDS are RF-based devices used for the manipulation and/or the diagnostics of charged particle beams to retrieve longitudinal/temporal properties

Conventional TDS: streaking in a fixed polarization (i. e. vertical or horizontal)

POLARizable X-band Transverse Deflection Structure – POLARIX TDS



The longitudinal distribution of the e-bunch is mapped into the transverse one thanks to the time dependent transversely deflecting field

$$\sigma_{t,R} \geq \frac{\sigma_{y0}}{S} = \sqrt{\frac{\varepsilon_{N,y}}{\gamma\beta_d}} \frac{pc}{eV_{\perp}} \frac{1}{ck_{rf} \sin(\Delta\psi_{ds})}$$

P. Craievich et al., **Post-undulator beam measurements with PolariX TDS in SwissFEL**, SPIE Optics + Opticselectronics – 26 April 2023, Prague, Czech Republic

THE POLARIX DIAGNOSTIC CAPABILITIES

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- Bunch length measurement (Method capable of fs and sub-fs longitudinal resolution)
- Longitudinal charge profile measurement (1D)
- Combined with dipole → longitudinal phase space measurement
- Combined with quadrupole scan or multi-screen lattice → slice emittance measurement on the plane perpendicular to the streaking direction, slice transverse phase space reconstruction - **slice emittance on different transverse planes**
- **Measure of the FEL-induced lasing effects imprinted on the electron beam longitudinal phase space: first reference C. Behrens et al., Nat. Comm. 5, 3762 (2014)**
- **5D/6D phase-space characterization becomes possible by different streaking planes and using tomographic methods**
- **Reconstruction of the 3D charge density**

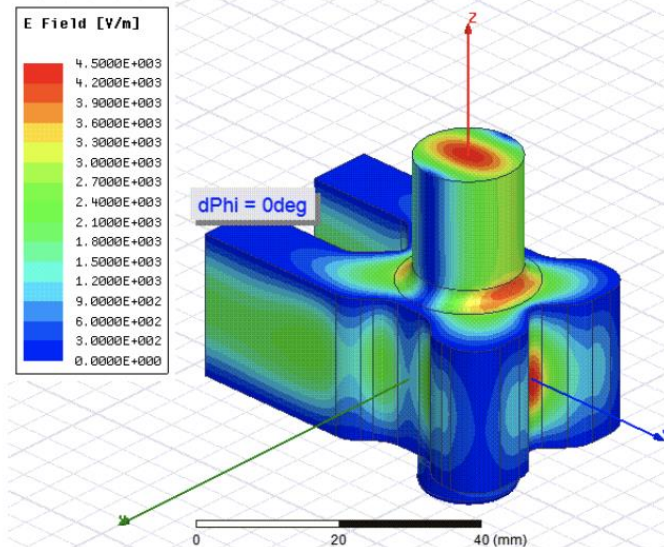


P. Craievich et al., **Post-undulator beam measurements with PolariX TDS in SwissFEL**, SPIE Optics + Opticselectronics
– 26 April 2023, Prague, Czech Republic

VARIABLE POLARIZATION – X BAND

Courtesy of P. Craievich - PSI

Variable polarization circular TE11 mode launcher: E-rotator



References:

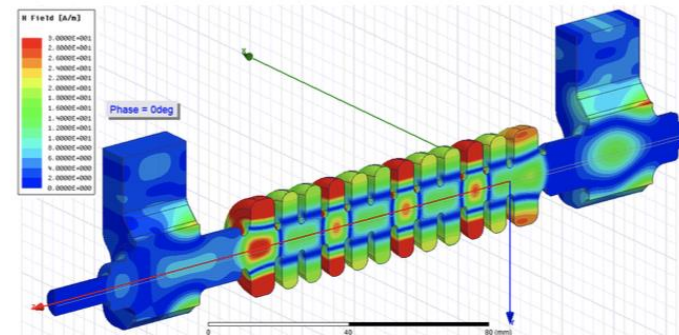
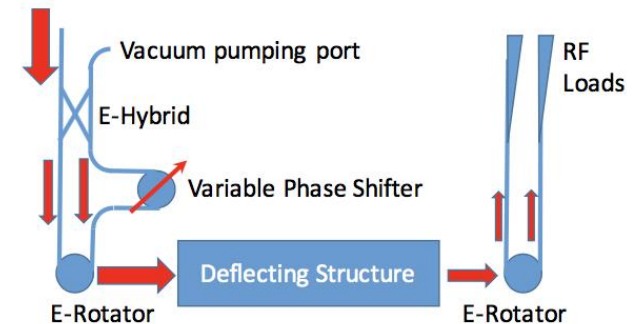
Grudiev, CLIC-Note-1067, 2016

P. Craievich et al., Phys. Rev. Accel. Beams, 2020

B. Marchetti et al., Sci. Rep., 2021

Phase difference between port 1 and port 2:

- 0 degree -> vertical polarization
- 180 degree -> horizontal polarization



P. Craievich et al., **Post-undulator beam measurements with PolariX TDS in SwissFEL**, SPIE Optics + Opticselectronics – 26 April 2023, Prague, Czech Republic

CONCLUSION

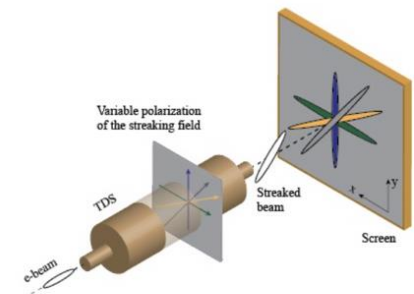
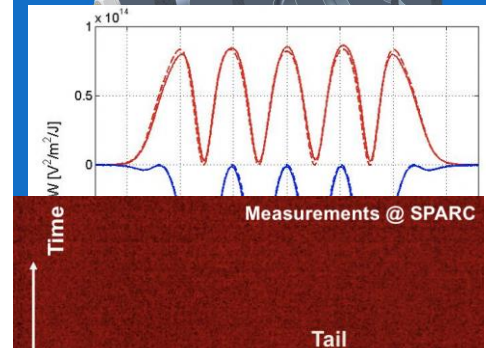
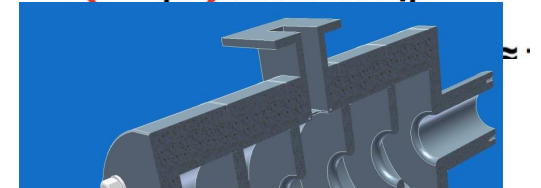
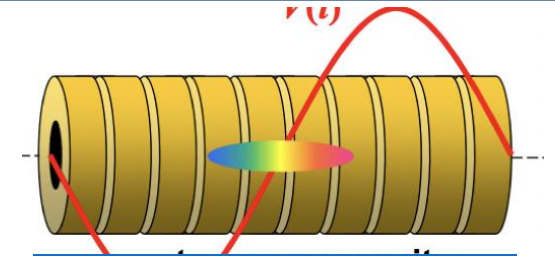
RF deflector for bunch length measurement

Various issues of **design and operating** a RF diagnostic device

Bead pull measurement of magnetic fields

Wakefields measurements

Novel ideas



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